

# From Finance to Flip Flops: Using the Mathematics of Money and Risk to Understand the Statistics of Nanoscale Circuits

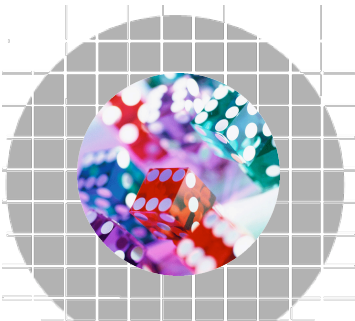
**Rob A. Rutenbar (and Amith Singhee)**  
Professor, Electrical & Computer Engineering  
rutenbar@ece.cmu.edu (and asinghe@us.ibm.com)

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**CarnegieMellon**

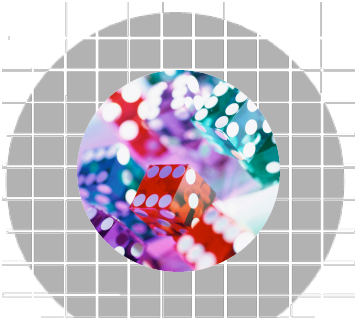
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## About This Talk



- **Statistics for nanoscale ckts**
  - The new challenge
- **Monte Carlo analysis**
  - How we do statistical analysis
- **Mathematics of money+risk**
  - Surprising source for very sophisticated Monte Carlo tools

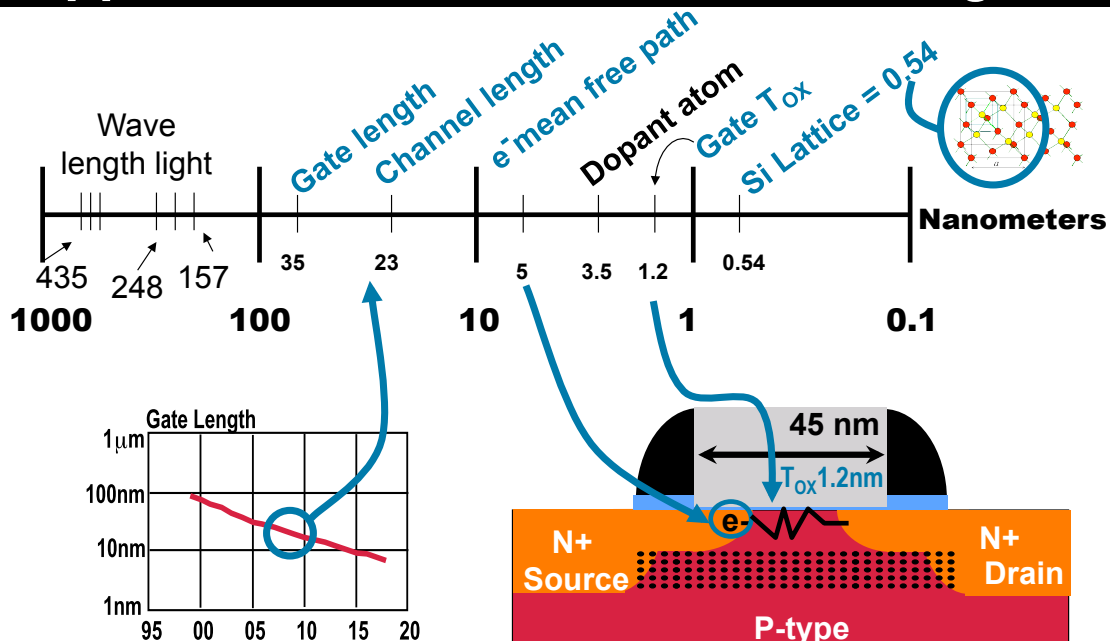
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## Approach Atomic Scale → Challenges

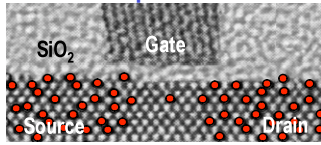


[Source: Scott Thompson, U Florida]

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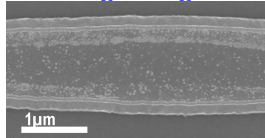
# One Challenge: *Statistical Variation*

## Random Dopant Fluctuations



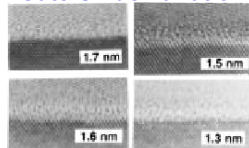
A. Brown et al., IEEE Trans. Nanotechnology, p. 195, 2002

## Line Edge Roughness

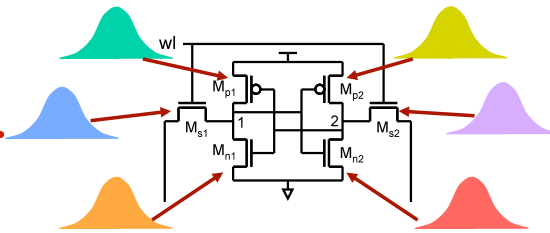


K. Shepard, U. Columbia

## Gate Oxide Variation



Momose et al, IEEE Trans. Electron Devices, 45(3), 1998



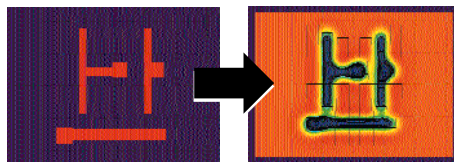
- At nanoscale, nothing is **deterministic** anymore
- Everything is **statistical**

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# Statistical Variability: Two Flavors

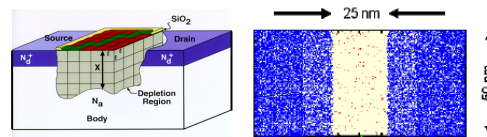
## ■ Systematic variation

- Ex: Lithography
- Optics, chemistry to print small mask shapes



## ■ Random variation

- Ex: Dopant fluctuation
- How many individual dopant atoms; where?



## ■ Not really random

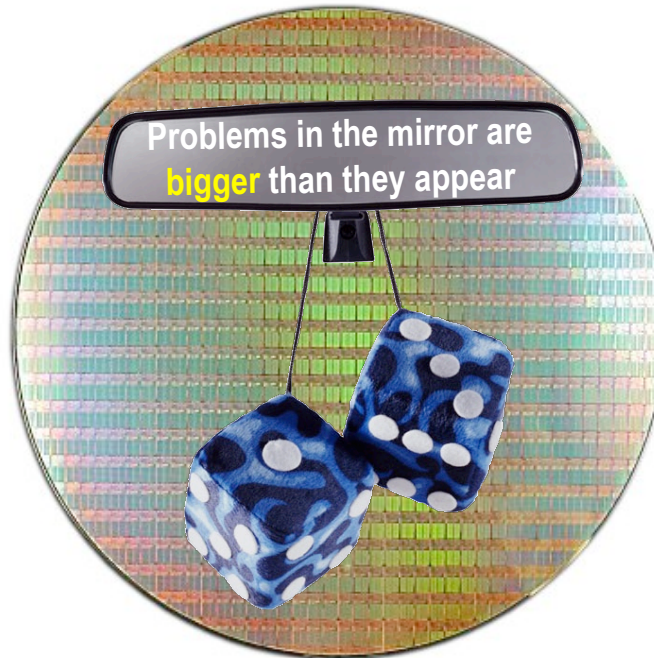
- Physics is understood, expensive to compute

## ■ Really (really) random

- Physics is fundamentally random for these effects

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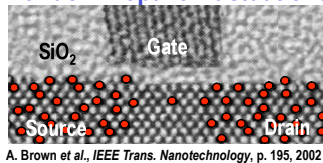
# End Result for Us Design/CAD Folks



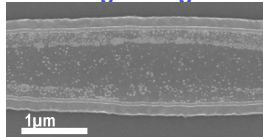
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## The Challenge: *Statistical Variation*

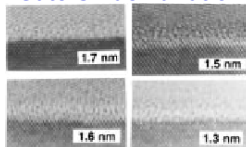
### Random Dopant Fluctuations



### Line Edge Roughness



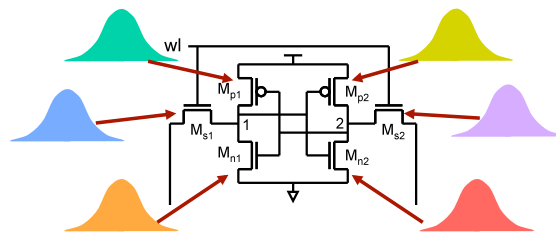
### Gate Oxide Variation



Momose et al, IEEE Trans. Electron Devices, 45(3), 1998

### Everything is *statistical*

- How do we analyze designs?



### Old: Delay = T

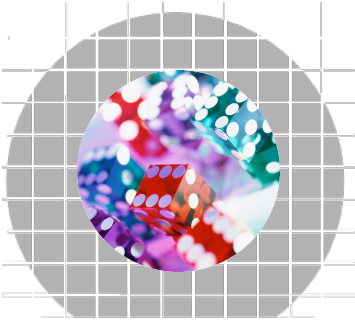
*Find T*

### New: Prob[Delay < T] = 0.9

*Find T*

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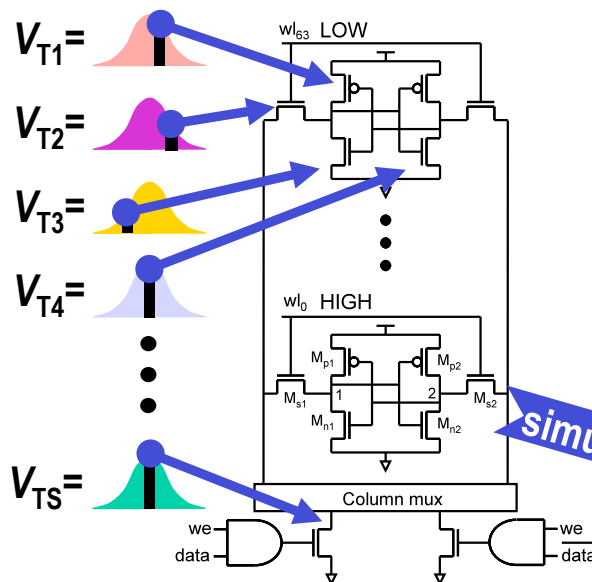
# About This Talk



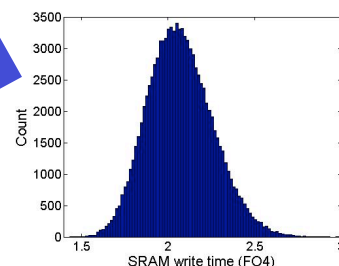
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  - The new challenge
- **Monte Carlo analysis**
  - How we do statistical analysis
- Mathematics of money+risk
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## To Evaluate Circuit Impact: *Monte Carlo*

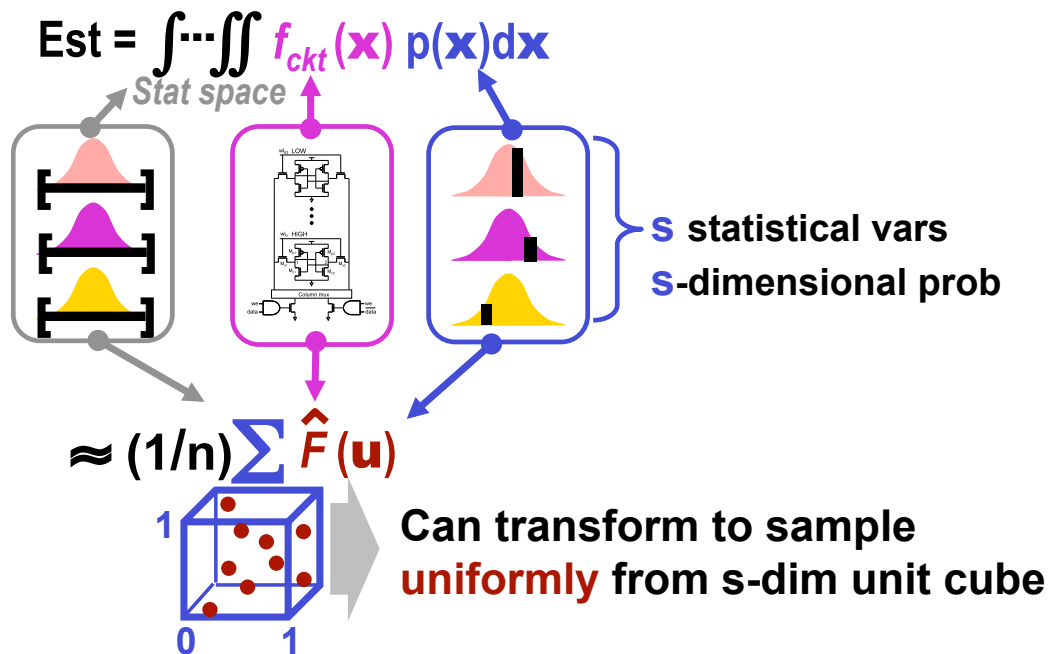


- Sample each statistical variable
- Parameterize one circuit, simulate it
- Repeat--n samples



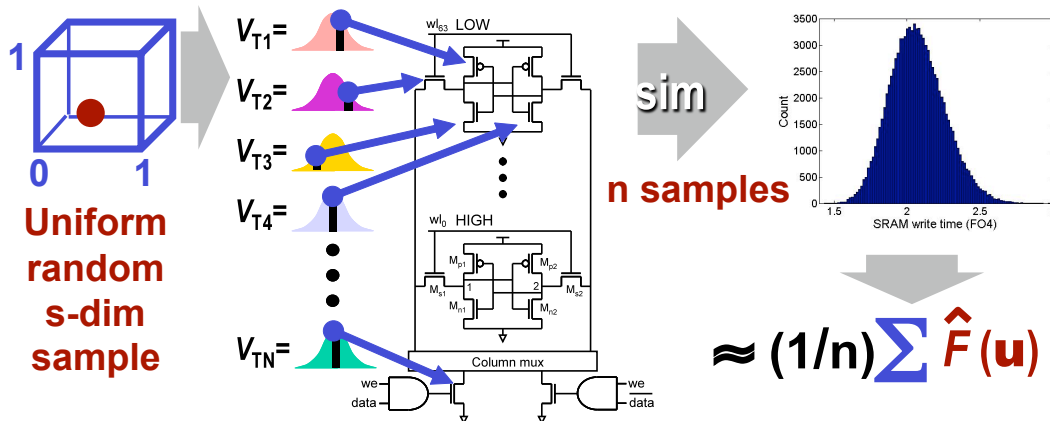
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# Monte Carlo Math: Just A Big Integral



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## Evaluate Circuit Impact: Monte Carlo



- PRO: Accurate, flexible, general
- CON: Slow, slow, **s l o w**...

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# Why is Monte Carlo Painful?

- High-dim problems: *s is big (100-1000)*
- Profoundly nonlinear: *Nanoscale physics*
- Accuracy matters: *~1-5% error*
- Speed matters: *Many samples*
- Samples expensive: *Simulate each circuit*

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## Question: Who *Else* Has This Problem?



### Computational finance

- Valuing complex financial instruments, derivatives
- High-dimensional, nonlinear, statistical integrals
- *Speed+accuracy* matters here, e.g., ~real-time decision-making

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## A Brief Aside: About “Finance...”

- These recruiting signs common in my building at CMU...
- ...*last year*



## A Brief Aside: In Defense of Finance...

- 12-18 months ago...
  - “Wow, analyzing yield is like pricing a bond? **Cool!**”
- 12-18 days ago...
  - “Wow, you’re using the same stuff that **killed Wall Street?!**”





# A Brief Aside: In Defense of Finance

HOME PAGE MY TIMES TODAY'S PAPER VIDEO MOST POPULAR TIMES TOPICS

The New York Times  
Tuesday, September 23, 2008

## Technology

### Bits

Business • Innovation • Technology • Society

September 18, 2008, 7:52 AM

#### How Wall Street Lied to Its Computers

By SAUL HANSELL

CORRECTED 5 p.m.: Spelling of Leslie Rahl.

So where were the quants?

That's what has been running through my head as I watch some of the oldest and seemingly best-run firms on Wall Street implode because of what turned out to be really bad bets on mortgage securities.

Before I started covering the Internet in 1997, I spent 13 years covering trading and finance. I covered my share of trading disasters from junk bonds, mortgage securities and the financial blank canvas known as derivatives. And I got to know bunch of quantitative analysts ("quants"): mathematicians, computer scientists and economists who were working on Wall Street to develop the art and science of risk management.



(Credit: Fred R. Conrad/The New York Times)

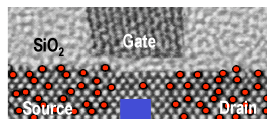
"The people who ran the financial firms **chose** to program their risk-management systems with **overly optimistic assumptions** and to feed them **oversimplified data**. ...

... Wall Street executives had **lots of incentives** to make sure their risk systems didn't see much risk."

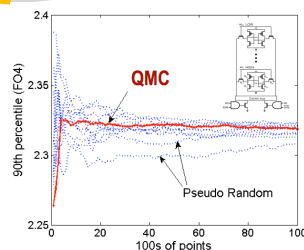
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# From Finance to Physics...

- Moral of story: If you start with **honest physics** as your input, you can get great results...



RDF

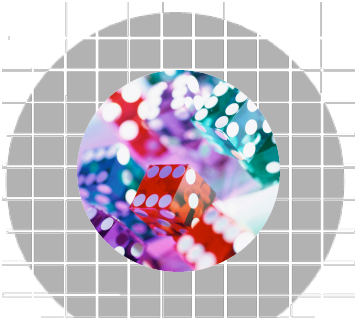


0% down!  
0% APR!



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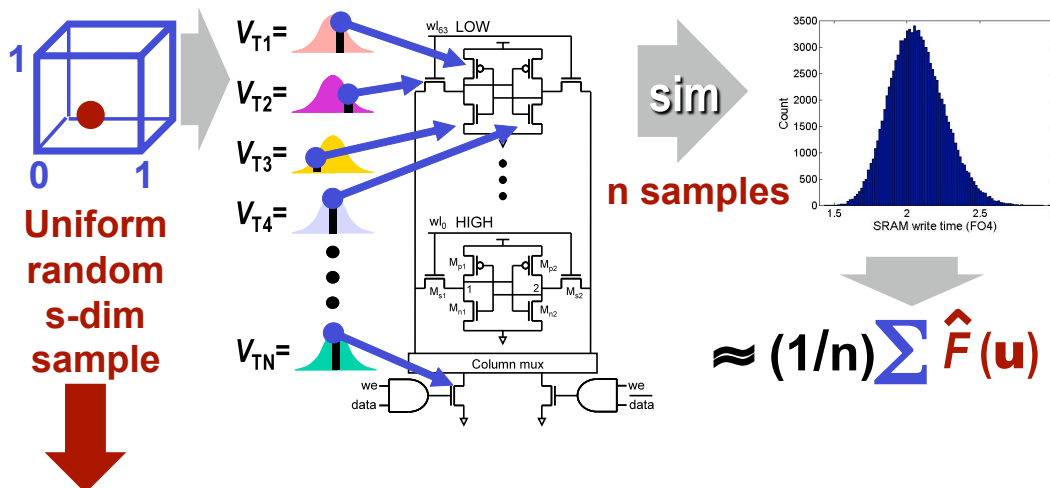
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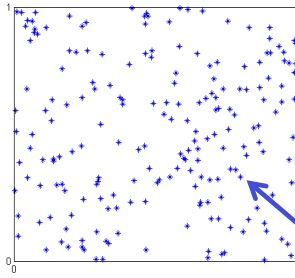
## Monte Carlo Revisited: Uniform Sampling



- Start from *uniform* random sampling in  $[0,1]^s$
- “Unit cube” thing seems like a *minor* detail
- ... but it turns out to be *crucial*

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# Monte Carlo: Uniform Sampling



**2-D example:** unit cube is  $[0,1]^2$

Independent, uniform  
random samples  
 $(x,y)$  in 2-D cube

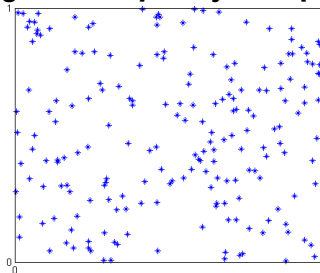
## ■ Classical Monte Carlo sampling

- Uses uniform pseudo-random pts (i.e, `rand()` )
- Surprise: *Not* very uniform
- See clumps, holes in 2D example
- Turns out this is inefficient

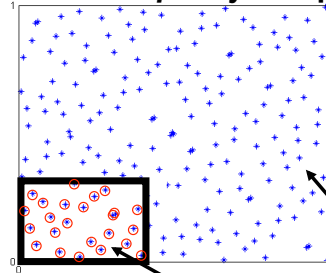
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# Uniformity Matters: Discrepancy

*High-discrepancy samples*



*Low-discrepancy samples*



$n$  points

$n_J$  points

Mathematically: the **discrepancy**  
is a measure of “uniformity”

$$D_n^* = \sup_J \left| \frac{n_J}{n} - Vol(J) \right|$$

Fraction of  
points in J

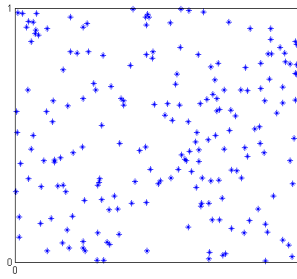
Fraction of volume  
occupied by J

How well does sampled  $n_J / n$   
approximate *relative volume* of box?

For *low-discrepancy* sequences,  
answer is: *always very well.*

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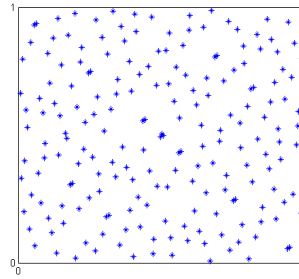
# Big Idea: Quasi Monte Carlo (QMC)



- **Classical Monte Carlo**
  - Uniform pseudo-random pts
  - Problem: *not* very uniform

- Error for n samples

$$O(1 / \sqrt{n})$$



- **Quasi Monte Carlo**
  - “Low-discrepancy” seq’s
  - *Deterministic* samples

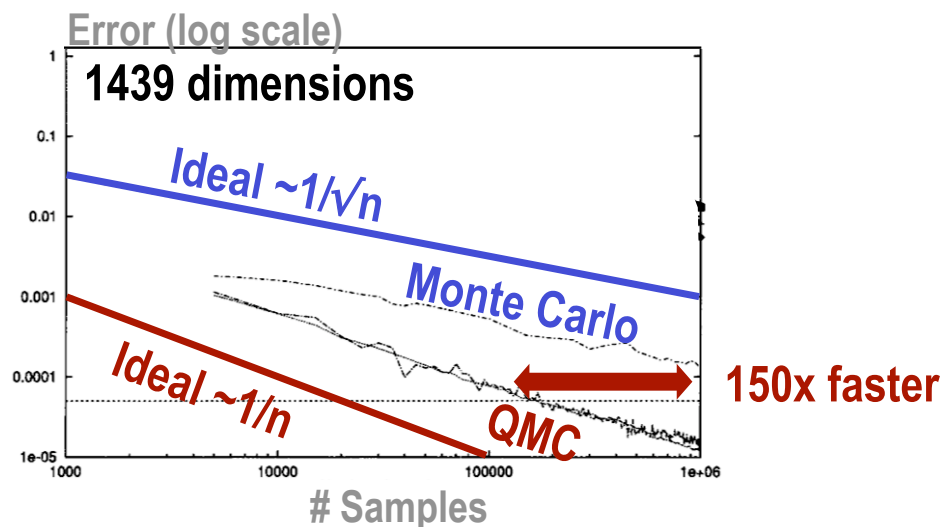
- Error for n samples

$$O(1 / n)$$

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## Computational Finance Example

- **Eval 5-year discount price for a bond**
  - From [Ninomiya, Tezuka, App Math Finance 1996]

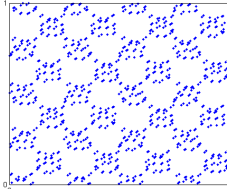


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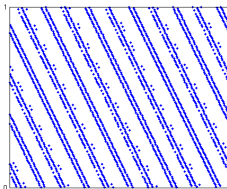
# New Problem: Pattern Artifacts

- Problem: Low Discrep Seq's show **patterns** in high dim's

- Need too many points for good uniformity



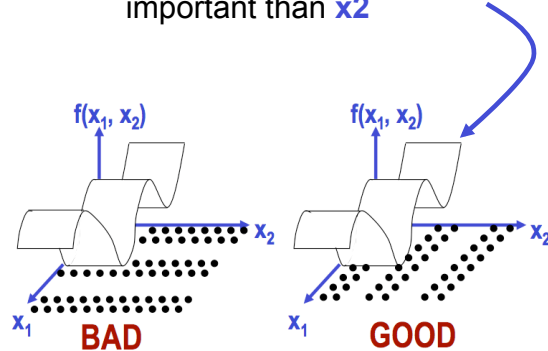
2 dims from 500-D Sobol' pts



2 dims from 500-D Faure pts

- Solution: Since *earlier* dimensions *less* affected...

- Calculate **statistical sensitivity** of all vars
- Put sensitive vars first
- Ex: in  $f(x_1, x_2)$  if  $x_1$  more important than  $x_2$



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## Putting It All Together

### QMC steps

1. **Run** small, initial Monte Carlo
2. **Compute** sensitivity  $R_i$  for every statistical param  $x_i$  and output  $y$
3. **Sort**  $x_i$  with decreasing sensitivity  $R_i$  for QMC sampling
4. **Foreach**( sample point  $X=(x_1, x_2, \dots)$  ) from low discrepancy seq
  - a. **Parameterize** circuit with  $X$
  - b. **Run** SPICE on this circuit

### Technical details

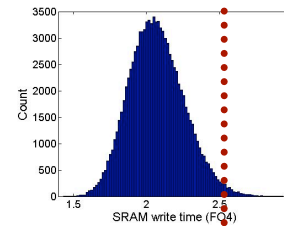
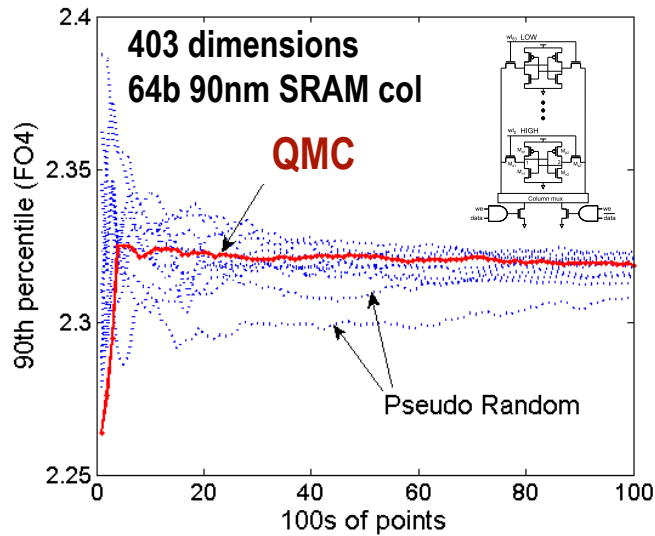
- For multiple outputs, **add** the correlations for each input before sorting the  $x_i$
- We use **Sobol'** LDS points for our experiments

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# Does QMC Work for Circuits?

## ■ Yes!

- See: [Singhee, Rutenbar, ISQED 2007]
- Example: Complete SRAM column @ 90nm

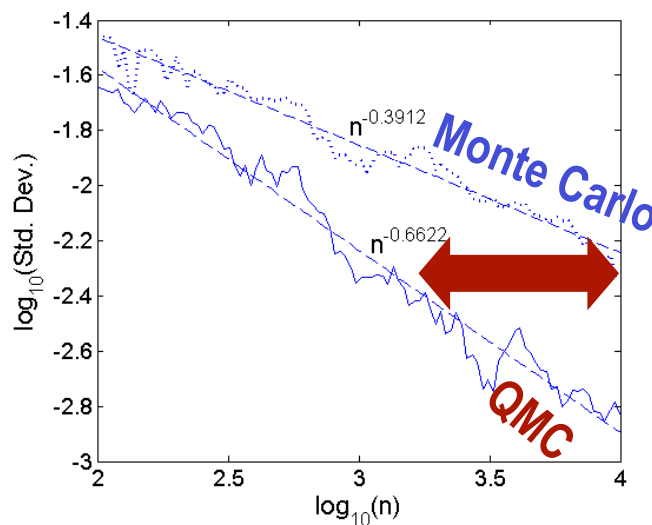


$$\Pr(\text{write} < t_w) = 0.9$$

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# Very Promising Speedups

- Same 403-dimensional, 64b SRAM column



~9x faster  
for 1% error

[Singhee, Rutenbar, ISQED 2007]

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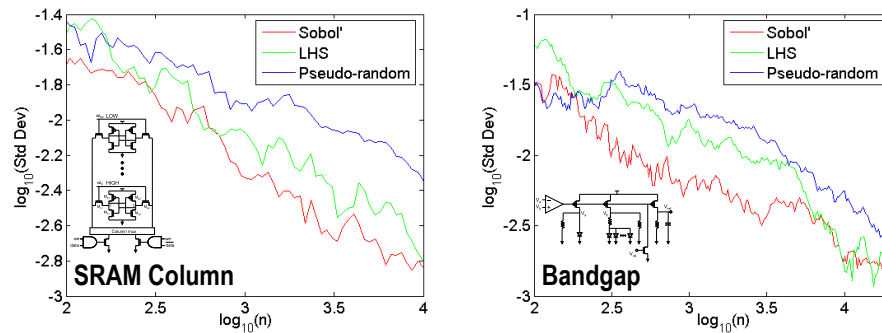


# Isn't This Just Latin Hypercube Sampling?

## No

- LHS sample set actually a *randomized* low-discrep seq
- Considered “advanced” in EDA, *but inferior* to QMC
- (Nobody prices bonds with LHS – it’s all QMC)

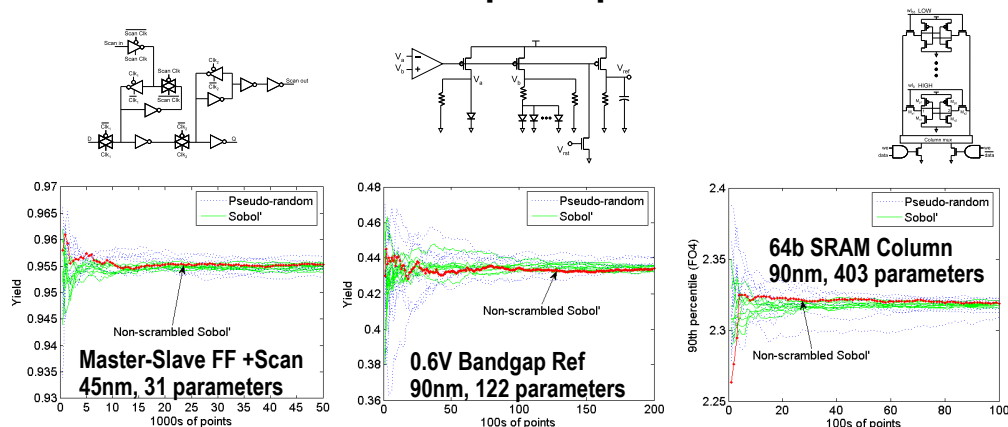
Plots: Error (est. variance across 10 runs) vs #samples  $n$



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# Good Behavior on Other Circuits

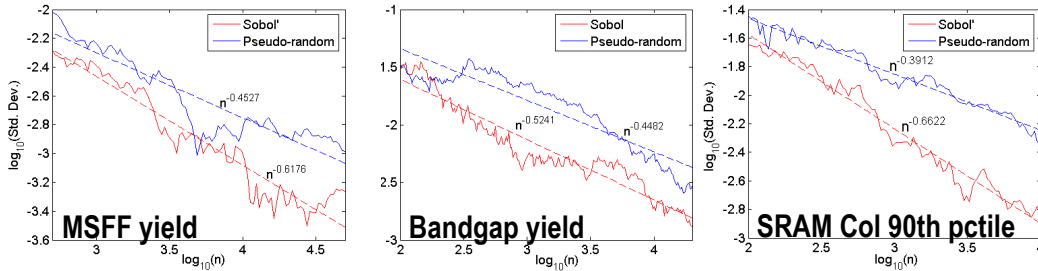
- MC vs QMC variance, with #samples,  $n$ 
  - 10 MC runs to compute MC variance
  - 1 QMC run + 9 *scrambled* QMC runs for variance
- General result: See speedups of **2X – 50X**



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# MC Variance vs. QMC Variance

- Plot: Est. variance (10 runs) vs #samples  $n$ 
  - Fit lines in log-log plot to estim convergence rate  $O(n^{-\alpha})$ .

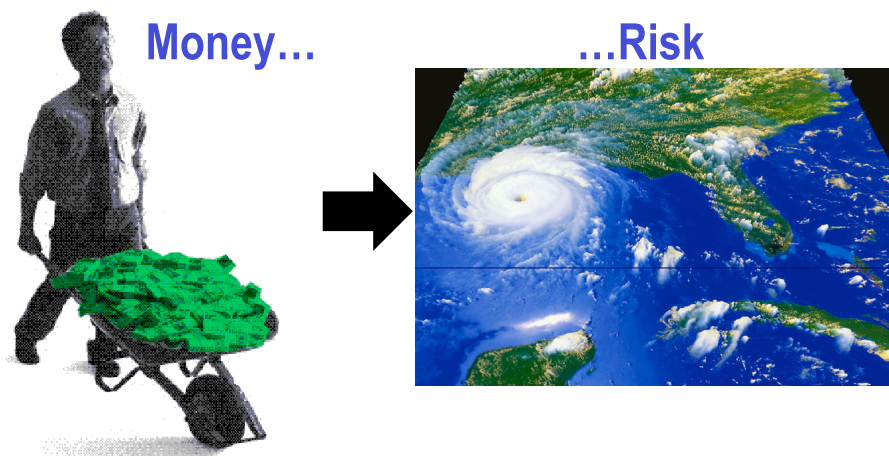


- Results
  - QMC always shows **lower variance** than MC
  - QMC always shows **faster convergence** than MC.

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## Are We Done Yet? (Nope...)

- Lots of ideas to exploit in this space



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# Another Aside: In Defense of Finance

HOME PAGE MY TIMES TODAY'S PAPER VIDEO MOST POPULAR TIMES TOPICS

The New York Times  
Tuesday, September 23, 2008

## Technology

### Bits

Business • Innovation • Technology • Society

September 18, 2008, 7:52 AM

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By SAUL HANSELL

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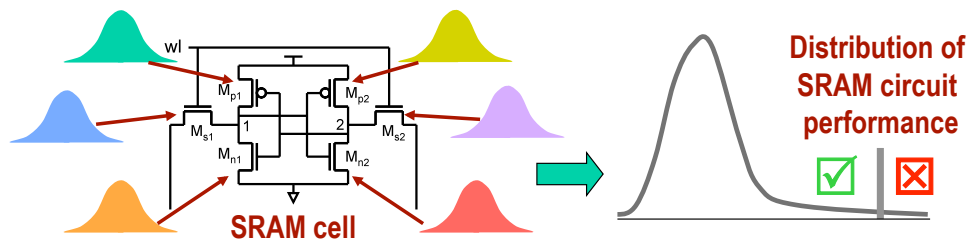
(Credit: Fred R. Conrad/The New York Times)

**"In fact, most Wall Street computer models radically underestimated the risk of the complex mortgage securities ... partly because the level of financial distress is 'the equivalent of the 100-year flood'..."**

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## Related Problem: "Rare Event" Statistics

- SRAM reliability is all about **far tails** of stats
  - Why? High replication ( $\sim 10^8$  bits) of core circuits
  - $3\sigma$  doesn't cut it for 100M cells; need  **$6\sigma$ ,  $7\sigma$ ,  $8\sigma$** ...

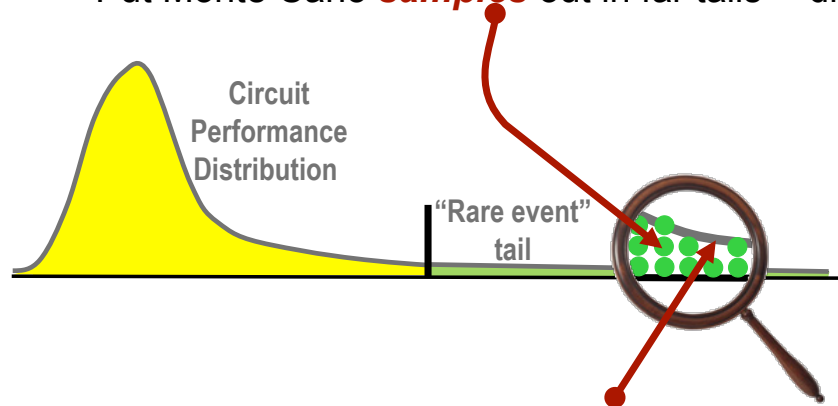


- Problem: **Intractable** Monte Carlo runs
  - 1M Monte Carlo sims predicts (unreliably) to  **$\sim 4.5\sigma$**

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# What Do We Need To Solve This...?

- Ultra fast **sampling** of rare events
  - Put Monte Carlo **samples** out in far tails -- directly

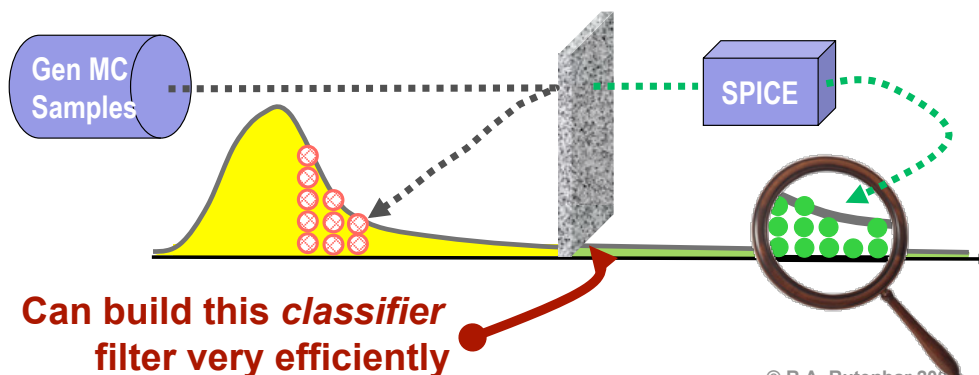


- Accurate analytical **pdf models** of rare tails
  - Using these samples, model lets us predict **farther**

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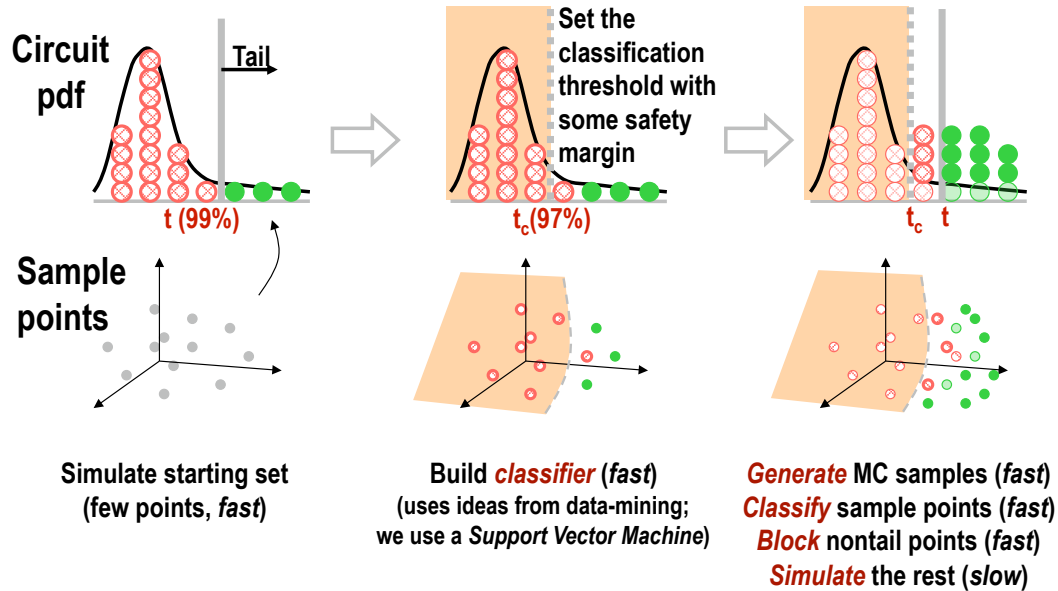
# Efficiently Sampling *Just* the Tail

- Note: **Generating** MC samples is cheap, **Simulating** these samples is costly
- Idea:
  1. **Generate** regular MC samples...
  2. ...but **block** points that are "very probably" **not** in tail
  3. **Simulate** the rest – i.e., the points we do not block



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# We Call the Idea: *Statistical Blockade*



[Singhee, Rutenbar DATE 2007]

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## Modeling Statistics of Rare Events...?



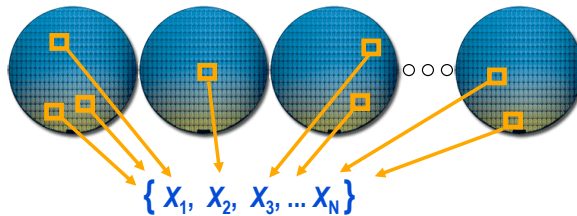
- **Extreme Value Theory (EVT)**
  - Behavior of extreme (rare) values of distributions
  - (If hurricanes are i.i.d random variables, we'd like to know the statistics of the *largest waves*...)

# EVT: Modeling the PDF in the Tail

- Recall Central Limit Theorem:  $\Sigma(\text{i.i.d. samples}) \rightarrow \text{Gaussian}$

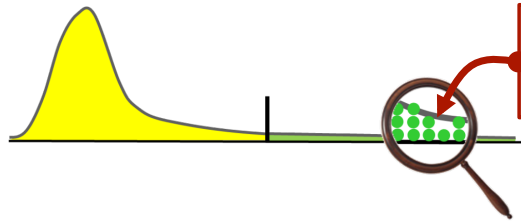
Question: Is there a similar result for these tails of “extreme” results ...?

Answer: YES – **Extreme Value Theory** (EVT)



On each of  $N$  wafers, identify cells **slower than threshold  $t$** . What is their **distrib**? EVT tells us!

- EVT gives simple analytical form for **conditional tail distrib**

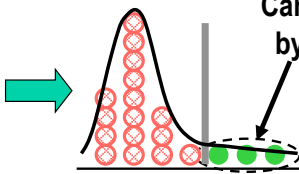


$$G_{a,k}(x) = \begin{cases} 1 - \left(1 + \frac{kx}{a}\right)^{1/k}, & k \neq 0 \\ 1 - e^{-x/a}, & k = 0 \end{cases}$$

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## EVT Says: GPD Form Fits Tail Stats

Run some sampling (Monte Carlo)

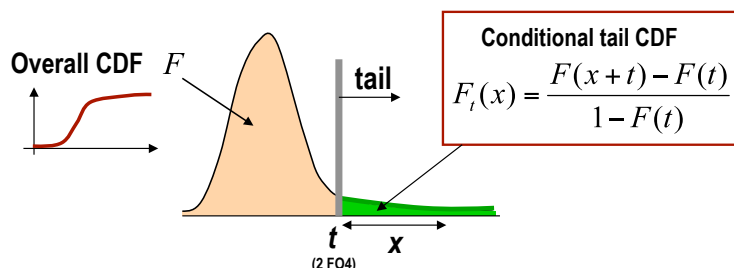


Can fit a **GPD** model to these tail points by fitting just 2 parameters

$$G_{a,k}(x) = \begin{cases} 1 - \left(1 + \frac{kx}{a}\right)^{1/k}, & k \neq 0 \\ 1 - e^{-x/a}, & k = 0 \end{cases}$$

- Aside: we actually fit the **conditional CDF** of the tail

Ex: **Prob[SRAM write-time > 2 FO4 delay]** – the bad values



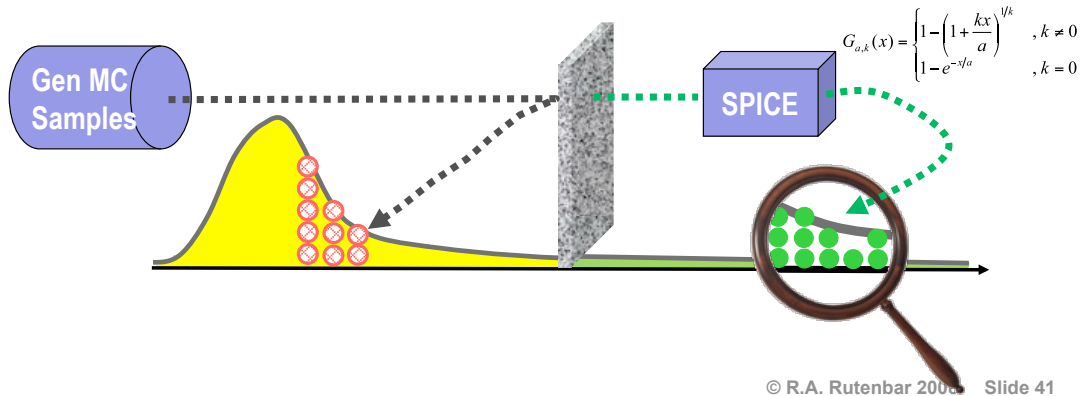
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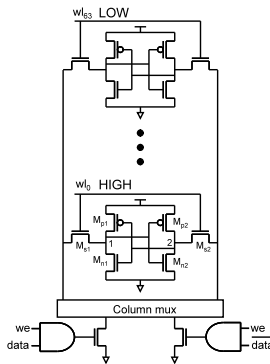
# Put It All Together: Statistical Blockade

## ■ Statistical Blockade

1. **Generate** small set of regular MC samples
2. **Build** classifier (the wall)
3. **Generate** many MC samples, use classifier to **block** nontail pts
4. **Simulate** the rest – i.e., the points we do not block
5. **Use** EVT-GPD theory to build **analytical model** of tail stats

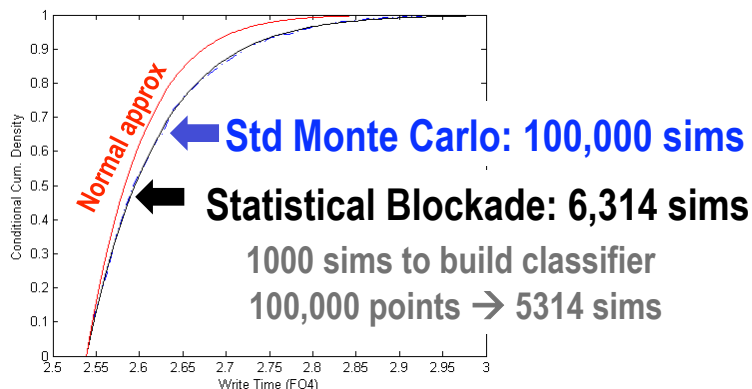


# Result: Complete 64b SRAM Column



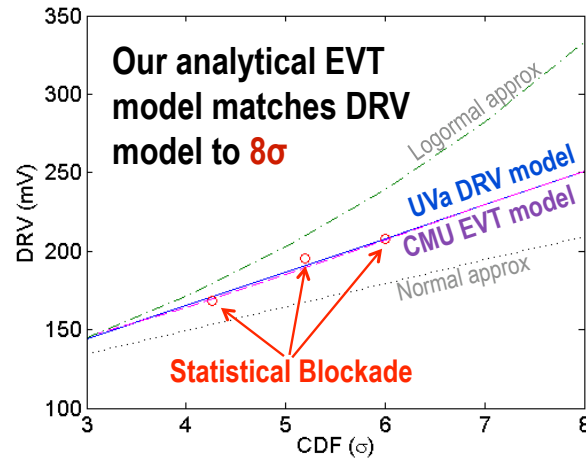
## ■ 90nm 64b SRAM column with write driver and column mux

- ~ 400 devices; model **Write-time CDF**
- **Speedup: ~16X**



# Result: Validating Model Out to $8\sigma$

- Recently validated novel analytical DRV model
  - Model of Data Retention Voltage, [Calhoun et al. UVa, ESSCIRC'07]
  - Validated to  $6\sigma$ , via **billion element** Monte Carlo run...
  - ...but only did 41,721 SPICE sims – **recursive** extension of Blockade
  - **Speedup ~23,000X**

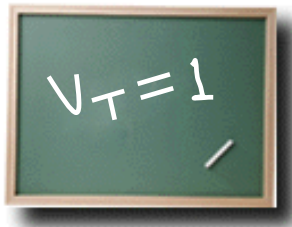


[Singhee et al,  
2008 Conf on VLSI Design]

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## Summarizing

Yesterday



Today, Tomorrow



- At nanoscale, nothing is deterministic...
- Brute-force Monte Carlo hurts (a lot)
- We can do ***much better with smart methods***
  - (Many of which involve \$\$\$ + risk...)
  - CMU results: **10x – 10,000x speedups**

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# Thank You!

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